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LIST OF REFERENCES CITED BY APPLICANT

APPLICANT
 Yasuhiro IWAMURA, et al.

FILING DATE
 October 19, 2001

GROUP
 3641

U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						
	AN						

RECEIVED
 APR 05 2004
 GROUP 3600

FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
	AO	196 49 511 /	06/04/1998	GERMANY		X
	AP	40 09 604 /	02/20/1992	GERMANY		X
	AQ	1 202 290	05/02/2002	EUROPE	376	100
	AR					

NO CITATION

OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

AS	Y. IWAMURA, et al., Fusion Technology, vol. 33, no. 4, XP-000779029, pages 476-492, "DETECTION OF ANOMALOUS ELEMENTS, X-RAY, AND EXCESS HEAT IN A D ₂ -PD SYSTEM AND ITS INTERPRETATION BY THE ELECTRON-INDUCED NUCLEAR REACTION MODEL", July 1998
AT	Y. IWAMURA, et al., Jpn. J. Appl. Phys., vol. 41, pt. 1, no. 7A, pages 4642-4650, "ELEMENTAL ANALYSIS OF PD COMPLEXES: EFFECTS OF D ₂ GAS PERMEATION", July 2002
AU	Y. IWAMURA, et al., Tenth International Conference on Cold Fusion, 11 pages, "LOW ENERGY NUCLEAR TRANSMUTATION IN CONDENSED MATTER INDUCED BY D ₂ GAS PERMEATION THROUGH PD COMPLEXES: CORRELATION BETWEEN DEUTERIUM FLUX AND NUCLEAR PRODUCTS", 2003
AV	T. HIGASHIYAMA, et al., Tenth International Conference on Cold Fusion, 7 pages, "REPLICATION OF MHI TRANSMUTATION EXPERIMENT BY D ₂ GAS PERMEATION THROUGH PD COMPLEX", 2003
AW	
AX	

☐ Additional References sheet(s) attached

Examiner

Date Considered

6/04

*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.